

INVERTER SCR's 500 TO 700 AMPERES

GE TYPE	C387	C388	C397	C398	C392	C393
CONSTRUCTION	AMPLIFYING GATE	AMPLIFYING GATE	AMPLIFYING GATE	AMPLIFYING GATE	AMPLIFYING GATE	AMPLIFYING GATE
ELECTRICAL SPECIFICATIONS						
VOLTAGE RANGE	500-1200	500-1200	500-1200	500-1200	100-600	100-600
FORWARD CONDUCTION						
I_T (RMS)	Max. forward conduction sinusoidal @ $T_C = 65^\circ\text{C}$, 50% duty (A)					
@ 60 Hz	550	550	700	700	500	500
@ 600 Hz	530	530	650	650	450	450
@ 1200 Hz	455	455	550	550	400	400
@ 2500 Hz	225	225	275	275	210	210
@ 5000 Hz	120	120	150	150	145	145
I_{TSM}	Max. peak one cycle, non-repetitive surge current (A)					
	5500	5500	7500	7500	5500	5500
$I_2 t$	Max. $I_2 t$ for fusing for 5 to 8.3 msec ($\text{A}^2 \text{sec}$)					
	120,000	120,000	230,000	230,000	100,000	100,000
$R\theta_{JC}$	Max. thermal impedance ($^\circ\text{C}/\text{W}$)					
	.06	.06	.06	.06	.06	.06
$t_d + t_r$	Typical turn-on time (μsec)					
	2	2	2	2	2	2
t_q	Turn-off time @ rated voltage and $T_J V_R = 50 \text{ V min.}$ (μsec) @ $20\text{V}/\mu\text{sec}$ reapplied					
	30	20	40	30	10	15
	@ $100\text{V}/\mu\text{sec}$ reapplied					
	35	25	50	35	12	18
	@ $200\text{V}/\mu\text{sec}$ reapplied					
	40	30	60	40	14	20
di/dt	Critical rate-of-rise of on-state current ($\text{A}/\mu\text{sec}$)					
	500	500	800	800	800	800
T_J	Junction operating temperature range ($^\circ\text{C}$)					
	-40 to +125 $^\circ\text{C}$	-40 to +125 $^\circ\text{C}$	-40 to +125 $^\circ\text{C}$	-40 to +125 $^\circ\text{C}$	-40 to +125 $^\circ\text{C}$	-40 to +125 $^\circ\text{C}$
BLOCKING						
dv/dt	Min. critical rate-of-rise off-state voltage exponential to rated V_{DRM} @ Max. T_J ($\text{V}/\mu\text{sec}$)					
	200	200	200	200	200	200
FIRING						
I_{GT}	Max. required gate current to trigger (mA)					
@ -40 $^\circ\text{C}$	300	300	300	300	400	400
@ 125 $^\circ\text{C}$	125	125	125	125	150	150
V_{GT}	Max. required voltage to trigger (V)					
@ -40 $^\circ\text{C}$	5	5	5	5	5	5
@ 125 $^\circ\text{C}$ (Min.)	.15	.15	.15	.15	.15	.15
VOLTAGE TYPES						
Repetitive Peak Forward and Reverse Voltages						
100					C392A	C393A
200					C392B	C393B
300					C392C	C393C
400					C392D	C393D
500	C387E	C388E	C397E	C398E	C392E	C393E
600	C387M	C388M	C397M	C398M	C392M	C393M
700	C387S	C388S	C397S	C398S		
800	C387N	C388N	C397N	C398N		
900	C387T	C388T	C397T	C398T		
1000	C387P	C388P	C397P	C398P		
1100	C387PA	C388PA	C397PA	C398PA		
1200	C387PB	C388PB	C397PB	C398PB		
PACKAGE TYPE	1" PRESS PAK	1" PRESS PAK	1" PRESS PAK	1" PRESS PAK	1" PRESS PAK	1" PRESS PAK
PACKAGE OUTLINE NO.	276	276	276	276	276	276

HIGH SPEED Silicon Controlled Rectifier 1200 Volts, 650 A RMS

C397/C398

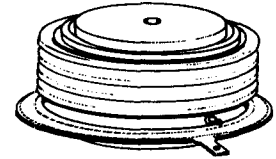


AMPLIFYING GATE

The General Electric C397 and C398 Silicon Controlled Rectifiers are designed for power switching at high frequencies. These are all-diffused Press-Pak devices employing the field-proven amplifying gate.

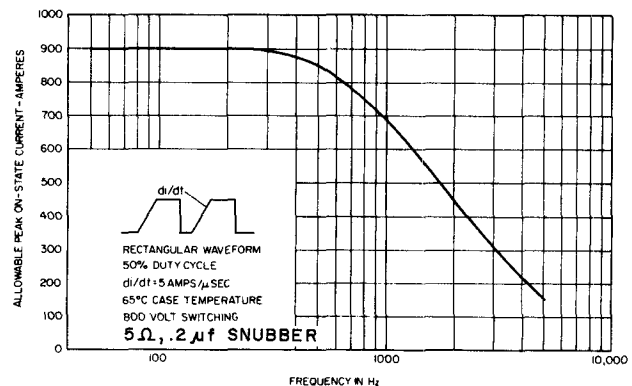
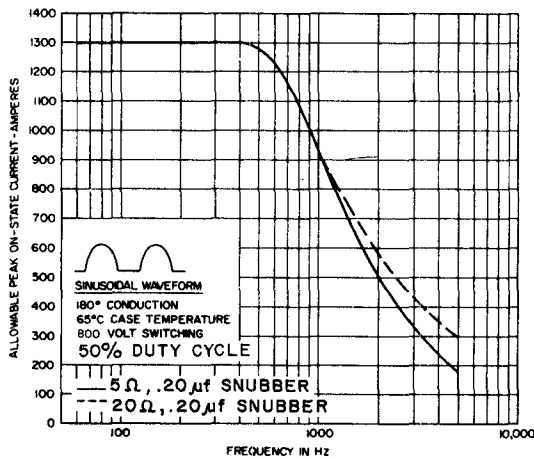
FEATURES:

- Fully characterized for operation in inverter and chopper applications.
- High di/dt ratings.
- High dv/dt capability with selections available.
- Rugged hermetic glazed ceramic package having 1" creepage path.



IMPORTANT: Mounting instructions on the mounting clamp specifications at back of this sheet **must** be followed.

HIGH FREQUENCY CURRENT RATINGS



Equipment designers can use the C397/C398 SCR's in demanding applications, such as:

- | | | |
|----------------------------|----------------------|---------------------------|
| • Choppers | • Sonar Transmitters | • Cycloconverters |
| • Inverters | • Induction Heaters | • DC to DC Converters |
| • Regulated Power Supplies | • Radio Transmitters | • High Frequency Lighting |

FOR SINEWAVE OPERATION

Like the Type C140/141, C158/159 and C358 SCR's, the C397/C398 SCR is rated for:

- Peak Current
- vs.
- Pulse Width
 - Frequency
 - Case Temperature

FOR RECTANGULAR WAVE OPERATION

GE now introduces a new, high-frequency rating for the C397/398 SCR, which is:

- Peak Current
- vs.
- di/dt of Leading Edge
 - Frequency
 - Duty Cycle
 - Case Temperature

MAXIMUM ALLOWABLE RATINGS

TYPES	REPETITIVE PEAK OFF-STATE VOLTAGE, V_{DRM}^1 $T_J = -40^\circ\text{C to } +125^\circ\text{C}$	REPETITIVE PEAK REVERSE VOLTAGE, V_{RRM}^1 $T_J = -40^\circ\text{C to } +125^\circ\text{C}$	NON-REPETITIVE PEAK REVERSE VOLTAGE, V_{RSM}^1 $T_J = 125^\circ\text{C}$
C397/C398E	500 Volts	500 Volts	600 Volts
C397/C398M	600	600	720
C397/C398S	700	700	840
C397/C398N	800	800	960
C397/C398T	900	900	1080
C397/C398P	1000	1000	1200
C397/C398PA	1100	1100	1300
C397/C398PB	1200	1200	1400

¹ Half sinewave waveform, 10 ms max. pulse width.

Peak One Cycle Surge (Non-Repetitive) On-State Current, I_{TSM}	7500 Amperes
I^2t (for fusing) for times ≥ 1.5 milliseconds	95,000 (RMS Ampere) ² Seconds
I^2t (for fusing) for times ≥ 8.3 milliseconds	230,000 (RMS Ampere) ² Seconds
Critical Rate-of-Rise of On-State Current, Non-Repetitive	800 A/ μs †
Critical Rate-of-Rise of On-State Current, Repetitive	500 A/ μs †
Average Gate Power Dissipation, $P_{G(AV)}$	2 Watts
Storage Temperature, T_{stg}	-40°C to +150°C
Operating Temperature, T_J	-40°C to +125°C
Mounting Force Required	2000 Lb. \pm 10%
	8.9 KN \pm 10%

†di/dt ratings established in accordance with EIA-NEMA Standard RS-397, Section 5.2.2.6 for conditions of max. rated V_{DRM} ; 20 volts, 20 ohms gate trigger source with 0.5 μs short circuit current rise time.

CHARACTERISTICS

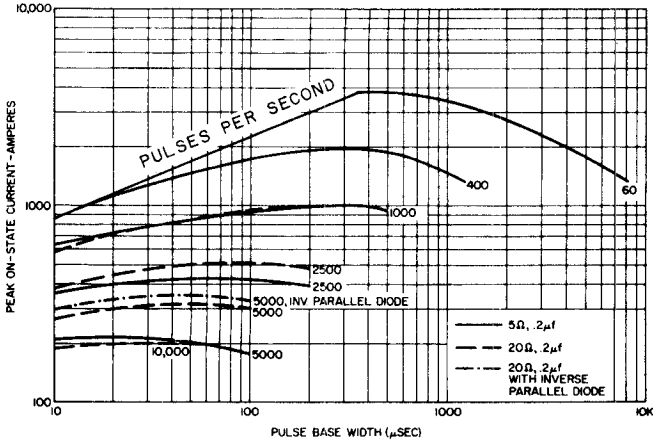
TEST	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITION
Repetitive Peak Reverse and Off-State Current	I_{RRM} and I_{DRM}	—	5	20	mA	$T_J = +25^\circ\text{C}$ $V = V_{DRM} = V_{RRM}$
Repetitive Peak Reverse and Off-State Current	I_{RRM} and I_{DRM}	—	20	45	mA	$T_J = 125^\circ\text{C}$ $V = V_{DRM} = V_{RRM}$
Thermal Resistance	$R_{\theta JC}$	—	.05	.06	$^\circ\text{C}/\text{Watt}$	Junction-to-Case (DC) (Double-Side Cooled)
Critical Rate-of-Rise of Off-State Voltage (Higher values may cause device switching)	dv/dt	200	500	—	V/ μsec	$T_J = 125^\circ\text{C}$, Gate Open. $V_{DRM} = \text{Rated}$, Linear or Exponential Rising Waveform. Exponential dv/dt = $\frac{V_{DRM}}{\tau}$ (.632)
Higher minimum dv/dt selections available – consult factory.						
DC Gate Trigger Current	I_{GT}	—	50	150	mAdc	$T_C = +25^\circ\text{C}$, $V_D = 6\text{ Vdc}$, $R_L = 3\text{ Ohms}$
		—	75	300		$T_C = -40^\circ\text{C}$, $V_D = 6\text{ Vdc}$, $R_L = 3\text{ Ohms}$
		—	15	125		$T_C = +125^\circ\text{C}$, $V_D = 6\text{ Vdc}$, $R_L = 3\text{ Ohms}$
DC Gate Trigger Voltage	V_{GT}	—	3	5	Vdc	$T_C = -40^\circ\text{C}$ to 25°C , $V_D = 6\text{ Vdc}$, $R_L = 3\text{ Ohms}$
		—	1.25	3.0		$T_C = 25^\circ\text{C}$ to $+125^\circ\text{C}$, $V_D = 6\text{ Vdc}$, $R_L = 3\text{ Ohms}$
		0.15	—	—		$T_C = 125^\circ\text{C}$, V_{DRM} , $R_L = 1000\text{ Ohms}$
Peak On-State Voltage	V_{TM}	—	2.7	3.0	Volts	$T_C = +25^\circ\text{C}$, $I_{TM} = 3000\text{ Amps Peak}$. Duty Cycle $\leq .01\%$. Pulse Width = 1 ms.
Turn-On Delay Time	t_d	—	0.5	—	μsec	$T_C = +25^\circ\text{C}$, $I_{TM} = 50\text{ Adc}$, V_{DRM} . Gate Supply: 20 volt open circuit, 20 ohms, 0.1 μsec max. rise time. ††, †††
Conventional Circuit Commutated Turn-Off Time (with Reverse Voltage)	t_q	—	20	†	μsec	(1) $T_C = +125^\circ\text{C}$ (2) $I_{TM} = 500\text{ Amps}$. (3) $V_R = 50\text{ Volts Min}$. (4) V_{DRM} (Reapplied) (5) Rate-of-rise of reapplied off-state voltage = 20 V/ μsec (linear) (6) Commutation di/dt = 25 Amps/ μsec (7) Repetition rate = 1 pps. (8) Gate bias during turn-off interval = 0 volts, 100 ohms
			35	†		
		—	30	40		
		—	45	60		
Conventional Circuit Commutated Turn-Off Time (with Feedback Diode)	$t_{q(\text{diode})}$	—	40	†	μsec	(1) $T_C = +125^\circ\text{C}$ (2) $I_{TM} = 500\text{ Amps}$ (3) $V_R = 1\text{ Volt}$ (4) V_{DRM} (Reapplied) (5) Rate-of-rise of reapplied off-state voltage = 200 V/ μsec (linear) (6) Commutation di/dt = 25 Amps/ μsec (7) Repetition rate = 1 pps. (8) Gate bias during turn-off interval = 0 volts, 100 ohms
		—	60	†		

†Consult factory for specified maximum turn-off time.

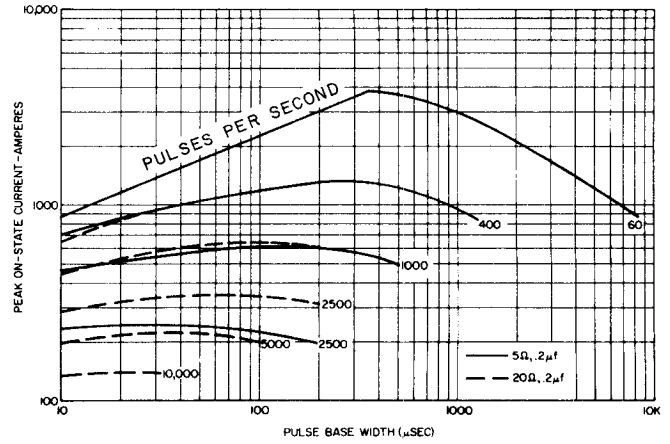
††Delay time may increase significantly as the gate drive approaches the I_{GT} of the Device Under Test.

†††Current risetime as measured with a current probe, or voltage risetime across a non-inductive resistor.

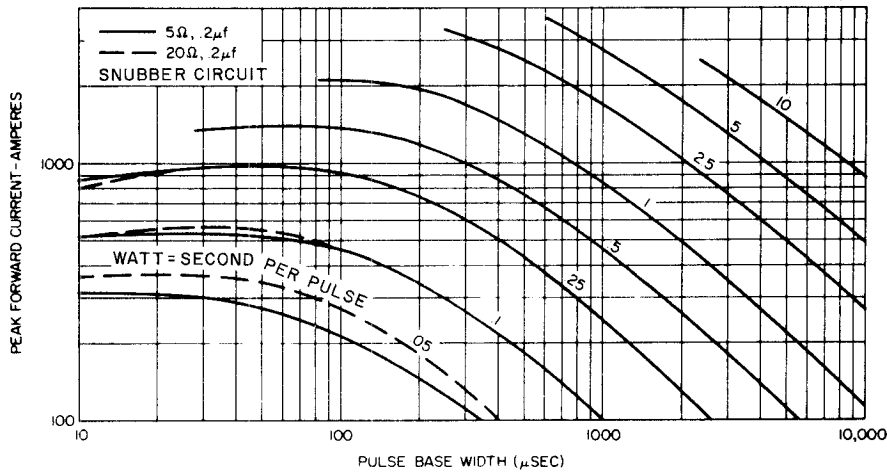
SINE WAVE CURRENT RATING DATA



1. MAXIMUM ALLOWABLE PEAK ON-STATE CURRENT VS. PULSE WIDTH ($T_C = 65^\circ C$)



2. MAXIMUM ALLOWABLE PEAK ON-STATE CURRENT VS. PULSE WIDTH ($T_C = 90^\circ C$)



3. ENERGY PER PULSE FOR SINUSOIDAL PULSES

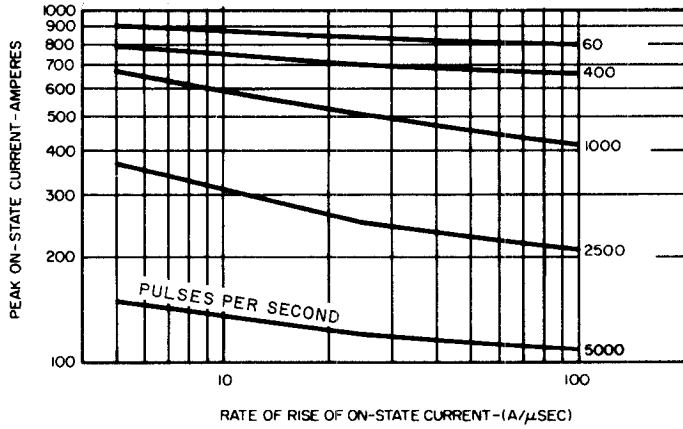
NOTES:

(Pertaining to Sine and Rectangular or Wave Current Ratings)

1. Switching voltage ≤ 800 volts.
2. Reverse voltage applied = $V_R \leq 800$ V.
3. Max. energy dissipated during reverse recovery is 15% of total W-S/P shown or 0.03 W-S/P whichever is least for operation with inverse diode.
4. Required gate drive:
 20 volts, 65 ohms, 1 μ sec risetime for less than 100 amps/ μ sec
 20 volts, 20 ohms, 5 μ sec risetime for greater than 100 amps/ μ sec.
5. RC Snubber ckt. = .2 μ f, 5 Ω
6. Double-Side Cooled.
7. Values of W-S/P are for $T_J = 125^\circ C$.

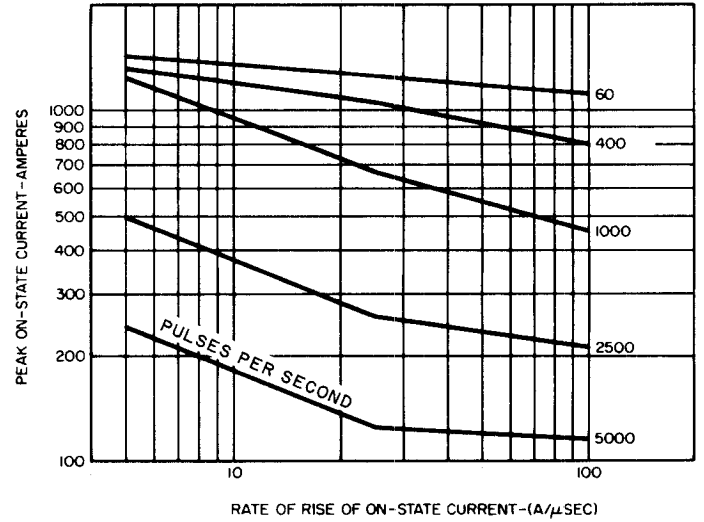
RECTANGULAR WAVE CURRENT RATING DATA

DUTY CYCLE - 50%

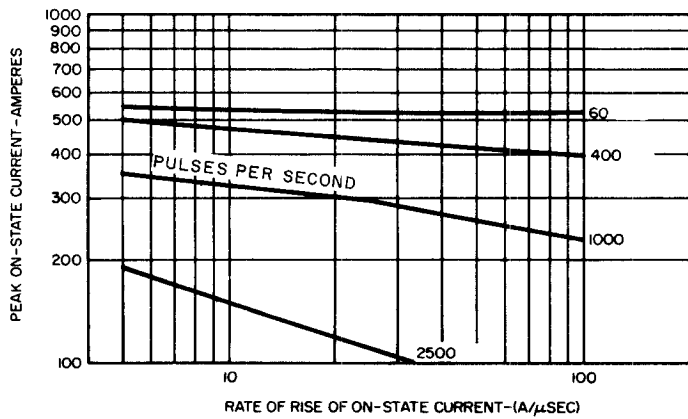


4. MAXIMUM ALLOWABLE PEAK ON-STATE CURRENT VS di/dt ($T_C = 65^\circ\text{C}$)

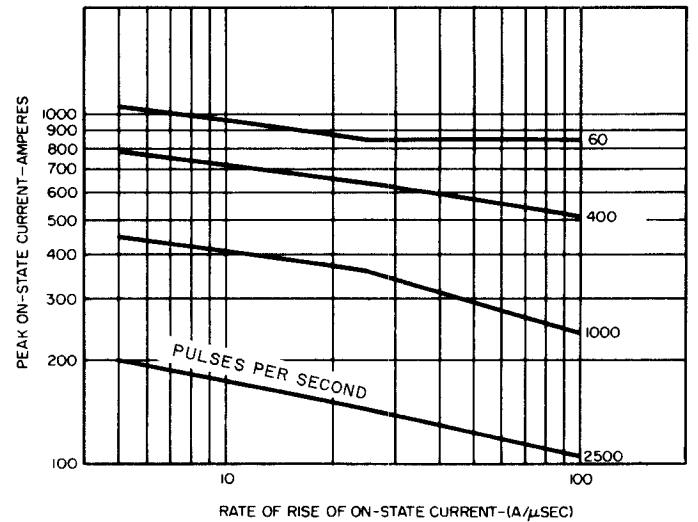
DUTY CYCLE - 25%



6. MAXIMUM ALLOWABLE PEAK ON-STATE CURRENT VS. di/dt ($T_C = 65^\circ\text{C}$)



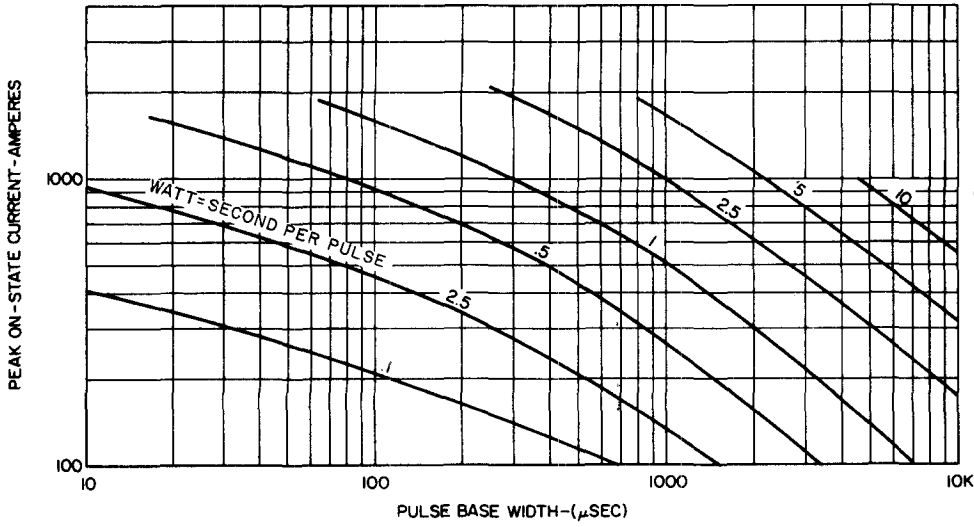
5. MAXIMUM ALLOWABLE PEAK ON-STATE CURRENT VS. di/dt ($T_C = 90^\circ\text{C}$)



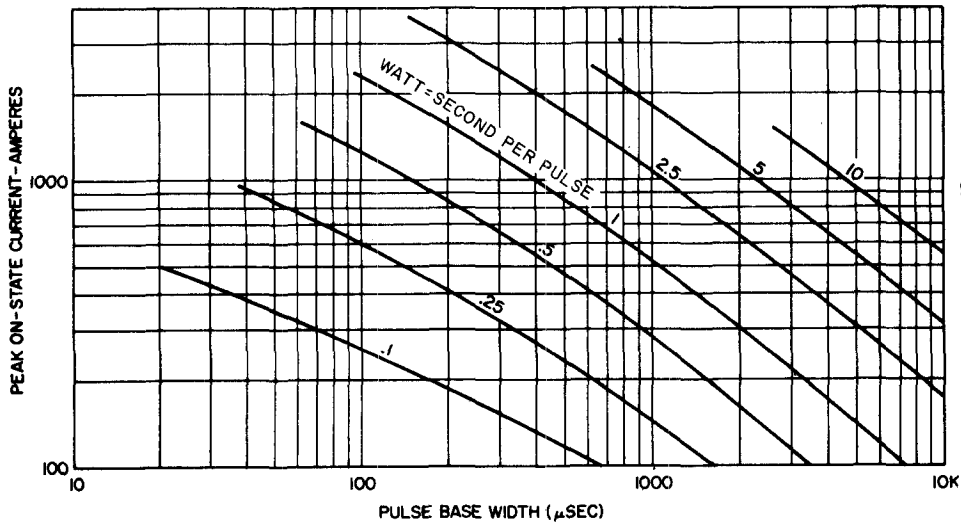
7. MAXIMUM ALLOWABLE PEAK ON-STATE CURRENT VS. di/dt ($T_C = 90^\circ\text{C}$)

NOTES: (SEE SINE WAVE DATA)

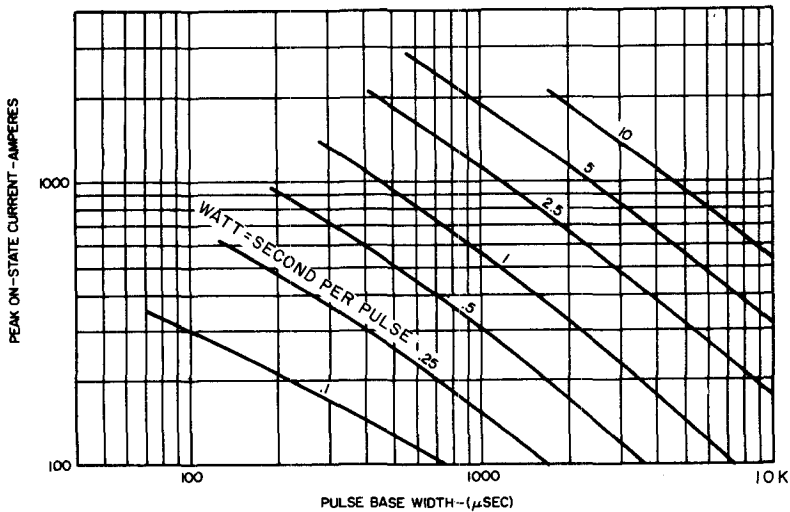
WATT-SECOND PER PULSE



8. ENERGY PER PULSE VS. PEAK CURRENT AND PULSE WIDTH ($di/dt = 100 \text{ A}/\mu\text{sec}$)

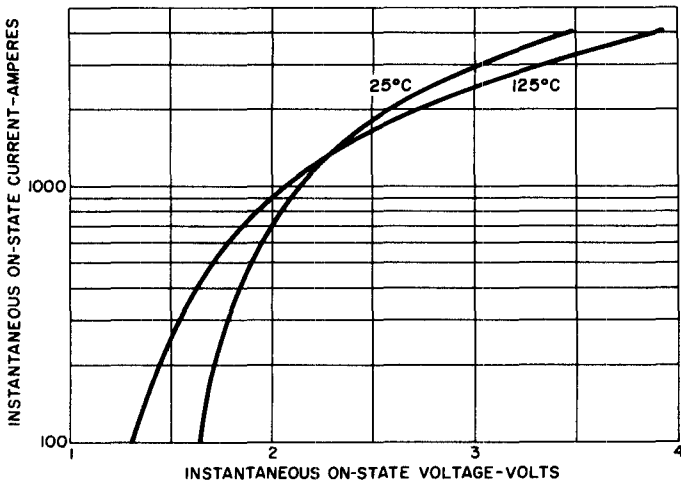


9. ENERGY PER PULSE VS. PEAK CURRENT AND PULSE WIDTH ($di/dt = 25 \text{ A}/\mu\text{sec}$)

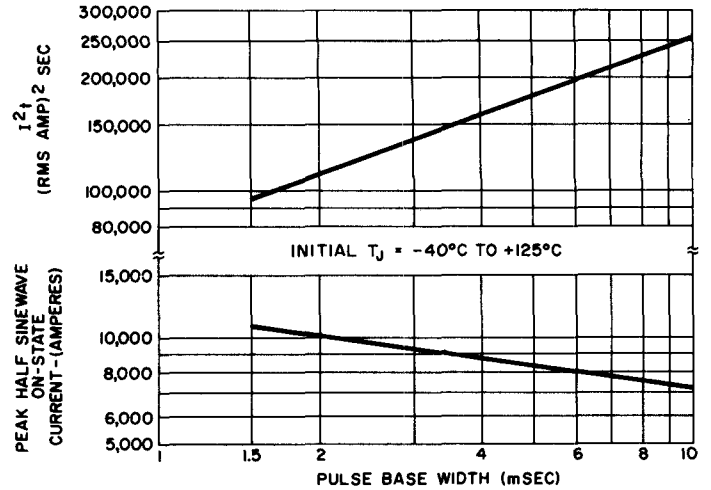


10. ENERGY PER PULSE VS. PEAK CURRENT AND PULSE WIDTH ($di/dt = 5 \text{ A}/\mu\text{sec}$)

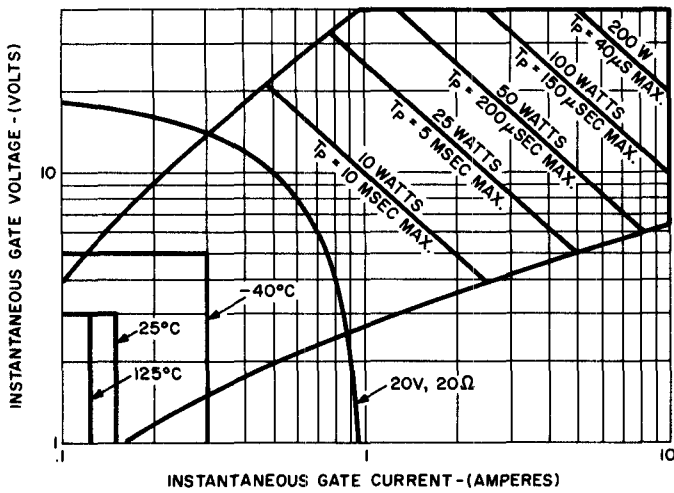
NOTES: (SEE SINE WAVE DATA)



11. MAXIMUM ON-STATE CHARACTERISTICS



14. SUB-CYCLE SURGE (NON-REPETITIVE) ON-STATE CURRENT AND I^2t RATING

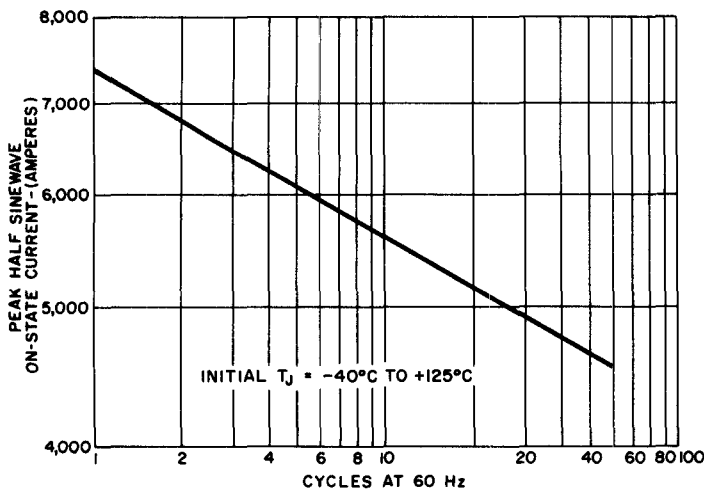


12. GATE TRIGGER CHARACTERISTICS AND POWER RATINGS

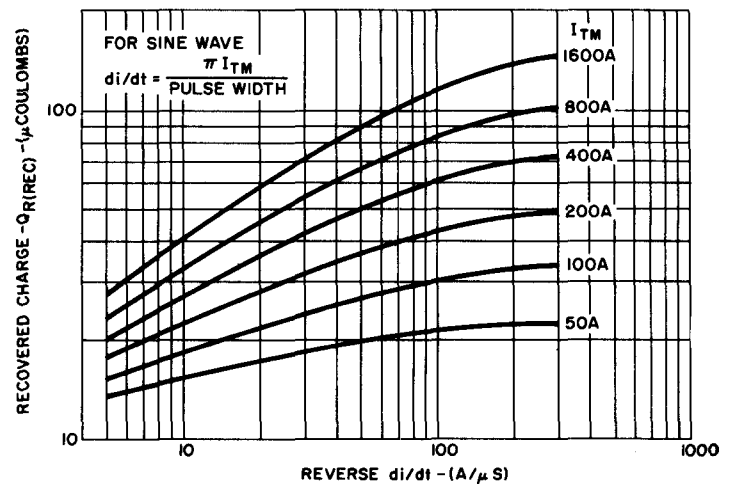
NOTES:

1. The locus of possible dc trigger points lies outside the boundaries shown at various case temperatures.
2. 20V - 20 is the minimum gate source load line when rate of circuit current rise $> 100 \text{ amp}/\mu\text{s}$ or anode rate of current rise $> 200 \text{ amps}/\mu\text{s}$ ($T_p = 5 \mu\text{s}$ min., 0.5 μs max. rise time.)

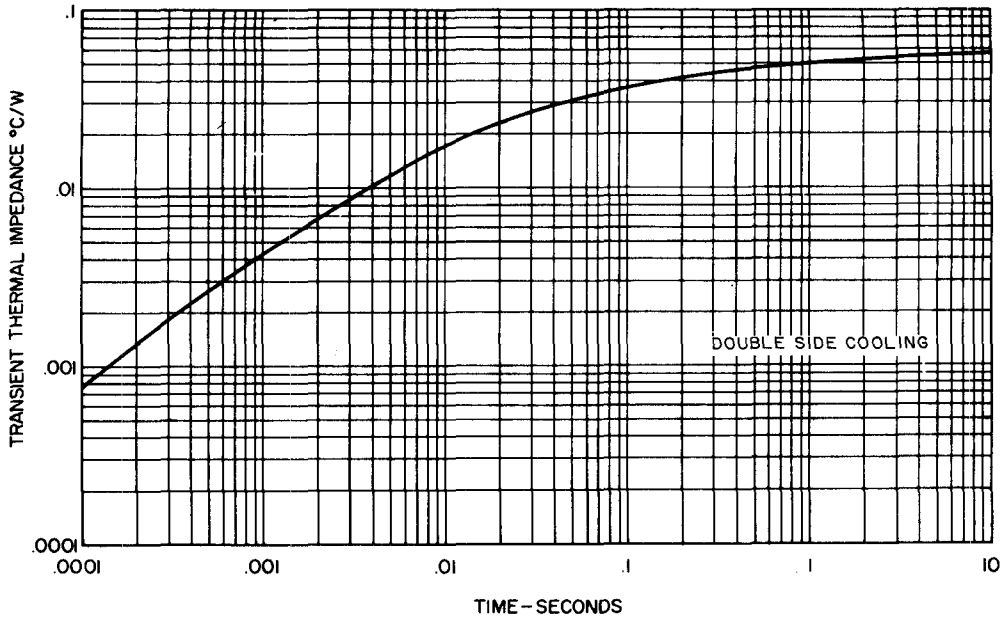
Maximum long term repetitive anode di/dt = 500 $\text{amps}/\mu\text{s}$ with 20V - 20 Ω gate source.



13. SURGE (NON-REPETITIVE) ON-STATE CURRENT

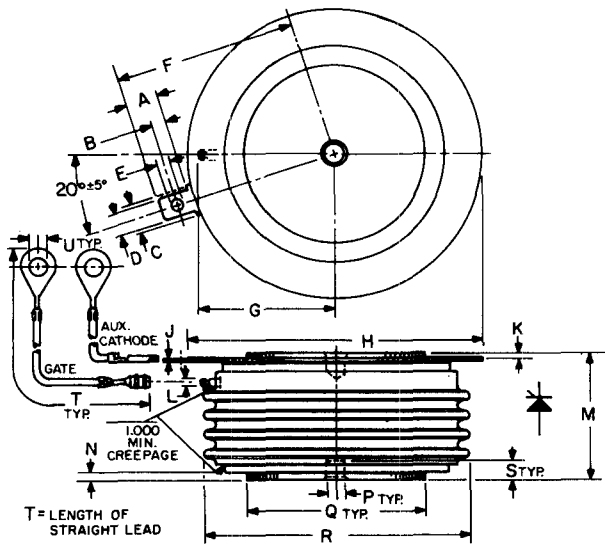


15. TYPICAL RECOVERED CHARGE (125°C) SINEWAVE CURRENT WAVEFORM



16. TRANSIENT THERMAL IMPEDANCE – JUNCTION-TO-CASE

OUTLINE DRAWING



SYM	DECIMAL INCHES		METRIC M.M.	
	MIN.	MAX.	MIN.	MAX.
A	.240	.260	6.096	6.604
B	.110	.130	2.794	3.302
C	.245		6.223	
D	.186	.191	4.724	4.851
E	.060	.075	1.524	1.905
F		1.430		36.32
G		1.065		27.061
H	2.200	2.500	55.88	63.50
J	.011	.019	2.794	3.483
K	.030	.130	.762	3.302
L	.056	.060	1.422	1.524
M	1.000	1.065	25.40	27.05
N	.030	.096	.762	2.438
P	.130	.150	3.302	3.810
Q	1.300	1.345	33.02	34.16
R		2.150		54.61
S	.067	.083	1.70	2.11
T	12.200	12.360	309.9	313.9
U	.137	.153	3.480	3.886